

Vishay Siliconix

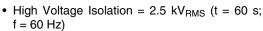
Power MOSFET

PRODUCT SUMMARY			
V _{DS} (V)	600		
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	4.4	
Q _g (Max.) (nC)	18		
Q _{gs} (nC)	3.0		
Q _{gd} (nC)	8.9		
Configuration	Single		

D

FEATURES

Isolated Package





• Sink to Lead Creepage Distance = 4.8 mm

- · Dynamic dV/dt Rating
- Low Thermal Resistance

Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. The isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

TO-220 FULLPAK	Θ
GDS	G
G D G	N-Channel MOSFET

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFIBC20GPbF
	SiHFIBC20G-E3
SnPb	IRFIBC20G
	SiHFIBC20G

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V_{DS}	600	V	
Gate-Source Voltage	V_{GS}	± 20	\ \ \		
Continuous Drain Current	V_{GS} at 10 V $T_C = 25 ^{\circ}C$	1-	1.7	А	
	$T_C = 100 ^{\circ}C$	I _D	1.1		
Pulsed Drain Current ^a	I _{DM}	6.8			
Linear Derating Factor			0.24	W/°C	
Single Pulse Avalanche Energy ^b	E _{AS}	84	mJ		
Repetitive Avalanche Current ^a	I _{AR}	1.7	Α		
Repetitive Avalanche Energy ^a	E _{AR}	3.0	mJ		
Maximum Power Dissipation	T _C = 25 °C	P_{D}	30	W	
Peak Diode Recovery dV/dtc	dV/dt	3.0	V/ns		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d		
Mounting Torque	C OO or MO corour		10	lbf ⋅ in	
	6-32 or M3 screw		1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 53 \,^{\circ}\text{mH}$, $R_G = 25 \,^{\circ}\Omega$, $I_{AS} = 1.7 \,^{\circ}\text{A}$ (see fig. 12).
- c. $I_{SD} \le 2.2$ A, $dI/dt \le 40$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.
- * Pb containing terminations are not RoHS compliant, exemptions may apply

IRFIBC20G, SiHFIBC20G

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	4.1		

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		600	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.88	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$		2.0	-	4.0	٧
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
Zoro Coto Voltago Drain Current	1	V _{DS} = 600 V, V _{GS} = 0 V		-	-	100	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 480 V	V _{DS} = 480 V, V _{GS} = 0 V, T _J = 125 °C		-	500	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 1.0 A ^b	-	-	4.4	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	V _{DS} = 50 V, I _D = 1.0 A ^b		-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 V$,		-	350	-	- pF
Output Capacitance	C _{oss}]	$V_{DS} = 25 V$		48	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	8.6	-	
Drain to Sink Capacitance	С		f = 1.0 MHz	-	12	-	
Total Gate Charge	Qg		$V_{GS} = 10 \text{ V}$ $I_D = 2.0 \text{ A}, V_{DS} = 360 \text{ V},$ see fig. 6 and 13 ^b	-	-	18	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	3.0	
Gate-Drain Charge	Q_{gd}	7		-	-	8.9	
Turn-On Delay Time	t _{d(on)}			-	10	-	
Rise Time	t _r	$V_{DD} = 300 \text{ V, } I_D = 2.0 \text{ A,}$ $R_G = 18\Omega, R_D = 150 \Omega,$ see fig. 10^b		-	23	-	ns
Turn-Off Delay Time	t _{d(off)}			-	30	-	
Fall Time	t _f			-	25	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	-11
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						•
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	1.7	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	6.8	A
Body Diode Voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 1.7 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 2.0 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s}^b$		-	290	580	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.65	1.3	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-or			ninated b	v L _S and I	-D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

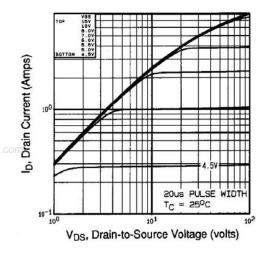


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

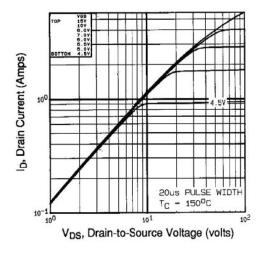


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

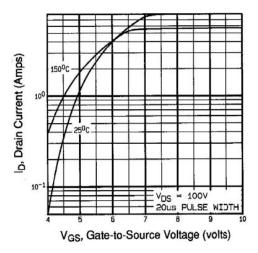


Fig. 3 - Typical Transfer Characteristics

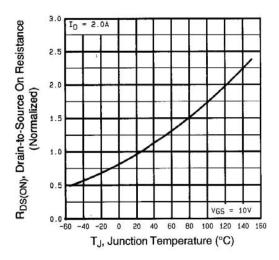


Fig. 4 - Normalized On-Resistance vs. Temperature

IRFIBC20G, SiHFIBC20G

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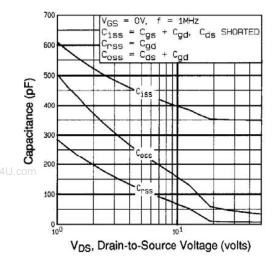


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

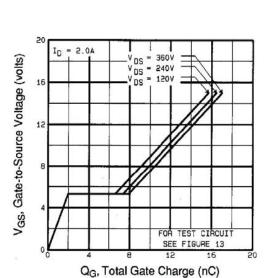


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

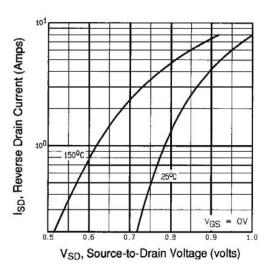


Fig. 7 - Typical Source-Drain Diode Forward Voltage

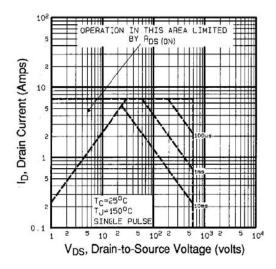


Fig. 8 - Maximum Safe Operating Area





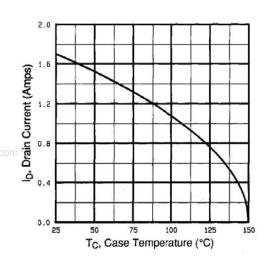


Fig. 9 - Maximum Drain Current vs. Case Temperature

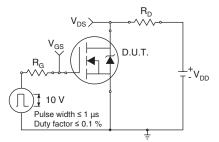


Fig. 10a - Switching Time Test Circuit

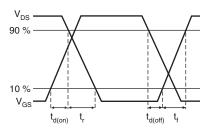


Fig. 10b - Switching Time Waveforms

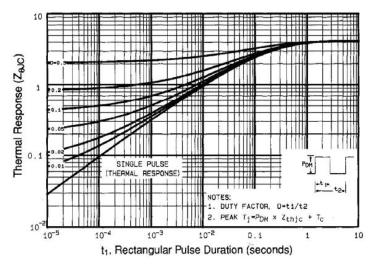


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

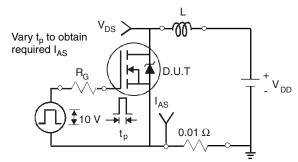


Fig. 12a - Unclamped Inductive Test Circuit

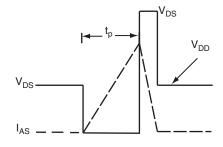


Fig. 12b - Unclamped Inductive Waveforms

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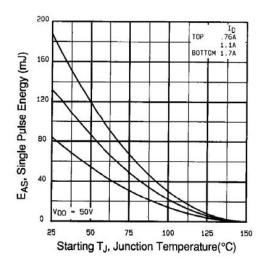


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

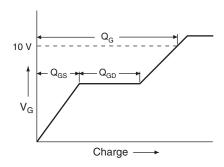


Fig. 13a - Basic Gate Charge Waveform

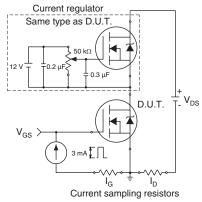
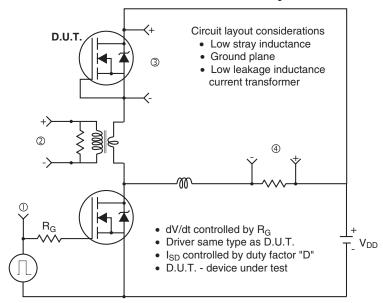


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



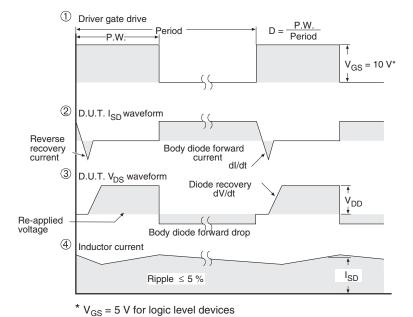


Fig. 14 - For N-Channel

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